Search Notes



Application/Control No.

.

Applicant(s)/Patent Under Reexamination

TAKENAKA ET AL.

Examiner

10549696

Art Unit

Freeman, John

1709

SEARCHED

Class	Subclass	Date	Examiner
351	166	8/30/2007	JF

SE	ΔR	CH	N	OT	FS
\mathbf{v}	$\boldsymbol{\neg}$		14		

Search Notes	Date	Examiner
Inventor Search	8/27/07	JF
STIC Database Search		JF

INTERFERENCE SEARCH

	·		
Class	Subclass	Date	Examiner
	. '		

U.S. Patent and Trademark Office Part of Paper No.: 20070828